Notice of References Cited Application/Control No. 10/824,758 Examiner MUHAMMAD N. EDUN Applicant(s)/Patent Under Reexamination ARAI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0181366	12-2002	Katayama, Ryuichi	369/53.2
*	В	US-2001/0008513	07-2001	Arai et al.	369/112.08
	С	US-			
	D	US-			# 11 of 1 of 1
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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